

Towards III-V on silicon solar cells

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GaP/Si heterojunctions for photovoltaics

- Tandem cells on silicon : high performance of multijunction solar cells on a classical photovoltaic substrate : silicon
- Epitaxial GaP layer as a transparent conductive layer on a single junction silicon solar cell to limit Si(n) absorption



➤ GaP(n)/Si(p) heterojunction to enhance V_{oc} and high energy absorption

GaP MBE 35 nm (500°C) GaP MEE 10 nm (350°C) Si (001) substrate 5.0 nm 3.0 2.0 1.0 1.0 0.0 Cross-sectional HRSTEM image of GaP epilayer grown on Si substrate

AFM : Weak roughness (RMS 0.3 nm)

Ping Wang, Y., Appl. Phys. Lett. 107, 191603 (2015)

State-of-the art GaP/Si(001) platform : Very low density of micro-twins annihilation of the antiphase domains after only 10 nm GaP growth

But doping GaP at the Si interface remains challenging

Ohmic contacts on GaP



Direct p-type ohmic contact on GaP requires exotic metal : Pd/Zn/Pd

Supplementary epitaxial GaAsP allows to use Ti/Pt/Au

20 nm GaAs_{0,1}P_{0,9} heavily doped : N_a=3. 10¹⁹ cm⁻³ Ohmic contact on GaP : $\rho c = 4.10^{-6} \Omega.cm^2$ after 35s annealing @ 375°C

Attempt of GaP/Si heterojunction solar cell

GaAsP(n++) 100 nm GaP/AlGaP(n++) 20 nm Si (p) 300 μm substrate

External quantum efficiency max :



GaP top cell optimization

Several studies already performed :

- Absorber layer optimization : Tg = 480°C, V/III = 10-11, Gr = 0,5ML/s
- Low carrier mobility in GaAsPN: 300 nm-thick absorber
- > Optimized composition : $GaAs_{0,1}P_{0.88}N_{0.02}$: pseudo-direct gap @ 1.7 eV, lattice matched to silicon
- New study : optimization of the n-doped layer



Low energy peak increases with n doping level: better current collection near the GaAsPN/GaP:n interface

First tandem cell on VPE Si pn junction



Poor electrical performances due to very bad contact on the Si side and carrier trapping at the doped GaP/Si interface : V_{OC} = 0,244 V, Efficiency : 0.45 %

Doping the GaP layer at the vicinity of the GaP/Si interface is a very strong issue because dopants seem to accumulate at APBs locally overpassing the solubility limit.

Further work :

- > optimizing Si contact and GaP/Si interface with dopants
- Using the GaP layer as transparent conductive layer on a Si homojunction



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